

Notice of References Cited	Application/Control No. 10/530,864		Applicant(s)/Patent Under Reexamination LELCUK ET AL.	
	Examiner Man Phan		Art Unit 2419	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,393,481	05-2002	Deo et al.	709/224
*	B	US-2002/0154646	10-2002	Dubois et al.	370/406
*	C	US-7,061,923	06-2006	Dugan et al.	370/396
*	D	US-6,425,005	07-2002	Dugan et al.	709/223
*	E	US-6,804,711	10-2004	Dugan et al.	709/223
*	F	US-5,655,081	08-1997	Bonnell et al.	709/202
*	G	US-6,418,461	07-2002	Barnhouse et al.	709/201
*	H	US-2005/0165906	07-2005	Deo et al.	709/217
*	I	US-7,170,905	01-2007	Baum et al.	370/467
*	J	US-6,829,250	12-2004	Voit et al.	370/467
*	K	US-6,798,751	09-2004	Voit et al.	370/252
*	L	US-2002/0156925	10-2002	Suzuki, Ken	709/249
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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